


 Cite this: *RSC Adv.*, 2020, **10**, 8016

Copper halide diselenium: predicted two-dimensional materials with ultrahigh anisotropic carrier mobilities†

 Fazel Shojaei,^{ab} Maryam Azizi,^{id b} Zabiollah MahdaviFar,^{id *a} Busheng Wang^c and Gilles Frapper^{id *c}

On the basis of first-principles calculations, we discuss a new class of two-dimensional materials—CuXSe₂ (X = Cl, Br) nanocomposite monolayers and bilayers—whose bulk parent was experimentally reported in 1969. We show the monolayers are dynamically, mechanically and thermodynamically stable and have very small cleavage energies of ~ 0.26 J m⁻², suggesting their exfoliation is experimentally feasible. The monolayers are indirect-gap semiconductors with practically the same moderate band gaps of 1.74 eV and possess extremely anisotropic and very high carrier mobilities (e.g., their electron mobilities are 21 263.45 and 10 274.83 cm² V⁻¹ s⁻¹ along the Y direction for CuClSe₂ and CuBrSe₂, respectively, while hole mobilities reach 2054.21 and 892.61 cm² V⁻¹ s⁻¹ along the X direction). CuXSe₂ bilayers are also indirect band gap semiconductors with slightly smaller band gaps of 1.54 and 1.59 eV, suggesting weak interlayer quantum confinement effects. Moreover, the monolayers exhibit high absorption coefficients (>10⁵ cm⁻¹) over a wide range of the visible light spectra. Their moderate band gaps, very high unidirectional electron and hole mobilities, and pronounced absorption coefficients indicate the proposed CuXSe₂ (X = Cl, Br) nanocomposite monolayers hold significant promise for application in optoelectronic devices.

 Received 10th December 2019
 Accepted 15th February 2020

DOI: 10.1039/c9ra10380e

rsc.li/rsc-advances

1. Introduction

Inspired by the discovery of graphene monolayers in 2004,¹ scientists have undertaken extensive research efforts to explore other two-dimensional (2D) materials. Due to their broad range of unique physicochemical and electronic properties, 2D materials hold promise for several technological applications, such as nanoelectronics,²⁻⁴ catalysis⁵⁻⁷ and energy conversion/storage.⁸⁻¹⁰ Chemical composition is well-recognized to determine the electronic properties of 2D materials, *i.e.*, graphene is a zero band gap material¹ while phosphorene is a semiconductor with a band gap of approximately 1.45 eV.¹¹ However, only a small number of 2D elemental compounds have actually been synthesized.¹² Most 2D materials are binary (A_xB_y) and ternary (A_xB_yC_z) compounds that exhibit highly diverse structural and electronic properties. In the last few years, 2D ternary compounds have received considerable research attention because of the higher possibility of tuning their properties due

to the multiple degrees-of-freedom in their chemical compositions. Metal phosphorus trichalcogenides (MPX₃: MnPSe₃, MnPS₃, FePS₃, *etc.*),¹³ ternary MXenes¹⁴ and ternary transition metal dichalcogenides¹⁵ are typical 2D ternary compounds.

Copper halogen dichalcogenides with the chemical formula CuXY₂, where X = Cl, Br or I and Y = Se or Te, are an emerging class of ternary layered materials.¹⁶⁻²⁰ Copper halide dichalcogenes were first synthesized in 1969¹⁶ and their crystal structures were identified in 1988.¹⁷ This class of materials is also called layered nanocomposites, as the chalcogen nanochains are inserted into the matrix of the CuX system. To the best of our knowledge—other than their experimental synthesis—there are very few reports on this class of material. However, the potential applications of CuClSe₂, the first copper halide dichalcogen to be synthesized, have been experimentally investigated in optoelectronic devices.^{21,22} Previous studies showed the compound is a semiconductor with an indirect band gap of 1.45 eV and very high absorption coefficients in the range of 10⁴–10⁵ cm⁻¹.²¹ Additionally, the low cost, convenient preparation, and high efficiency of CuClSe₂ make it a promising light absorber material that could potentially be exploited in solar cells. Therefore, it is of great importance to understand the electronic and optical properties of this type of material.

In this work, we studied the stability and mechanical, electronic and optical properties of CuXSe₂ (X = Cl, Br) monolayers using first-principles calculations. The monolayers are predicted to possess good dynamic, mechanical and thermodynamic

^aDepartment of Chemistry, Faculty of Science, Shahid Chamran University of Ahvaz, Ahvaz, Iran. E-mail: z_mahdaviFar@scu.ac.ir; Fax: +98-611-3331042

^bSchool of Nanoscience, Institute for Research in Fundamental Sciences (IPM), P. O. Box: 19395-5531, Tehran, Iran

^cIC2MP UMR 7285, Université de Poitiers – CNRS, 4, Rue Michel Brunet TSA 51106-86073, Cedex 9, Poitiers, France. E-mail: gilles.frapper@univ-poitiers.fr

† Electronic supplementary information (ESI) available. See DOI: 10.1039/c9ra10380e



stabilities. The CuXSe₂ monolayers can be easily exfoliated from the bulk, indicating weak interlayer interactions. The monolayers are semiconductors with indirect band gaps of 1.73 eV for CuClSe₂ and 1.74 for CuBrSe₂. Remarkably, extremely anisotropic and very high mobilities of $\sim 10^4$ cm² V⁻¹ s⁻¹ for electrons and $\sim 10^3$ cm² V⁻¹ s⁻¹ for holes are observed for both materials, implying efficient separation of photo-generated electrons and holes. In addition, the monolayers show strong absorption over a wide range of the visible light spectrum, indicating their promising potential as light absorber materials.

2. Theoretical methods

The first-principles calculations use a plane-wave basis with an energy cutoff of 400 eV and the projector augmented wave (PAW)²³ method as implemented in the Vienna *Ab initio* Simulation Package (VASP) code.^{24,25} For structure (shape, volume, and atomic positions) and energy determination, the Perdew–Burke–Ernzerhof (PBE) functional²⁶ at the generalized gradient approximation (GGA)²⁶ level of theory was used, if not otherwise noted. We investigated the performance for structural parameters and cleavage energy for a selective set of vdW DFT methods (optB88, SCAN-rVV10, DFT-dDsC, FIA and PBE-D2, using standard production settings in VASP code) in modeling non-covalent vdW interactions in layered bulk CuXSe₂ (X = Cl, Br) structures. Calculated structural parameters and cleavage energies are tabulated in Table S1 in ESI.† Considering both accuracy and computationally efficiency, Grimme's D2 correction (PBE-D2)²⁷ is selected for this work. For the 2D systems, we set a sufficiently large vacuum space to avoid interactions between neighboring images. K-point sampling was performed using Γ -centered $10 \times 8 \times 6$ and $10 \times 8 \times 1$ for bulk and 2D systems, respectively. All of the structures were fully optimized until the net forces on atoms were below 1 meV Å⁻¹, resulting in enthalpies that converged to better than 1 meV per atom. Since PBE is known to systematically underestimate the band gap for semiconductors, the Heyd–Scuseria–Ernzerhof hybrid functional (HSE06) was employed for high-accuracy electronic structure calculations.²⁸

In order to evaluate the dynamic stability of the monolayers, phonon dispersion relations were calculated by employing density functional perturbation theory (DFPT), as implemented in the Phonopy package,^{29,30} using VASP as the force-constant calculator. To further verify the thermal stability of the monolayers, Nose–Hoover *ab initio* molecular dynamics (AIMD) simulations were performed for constant NVT systems with a time step of 1.0 fs and Γ -point sampling (see Computational details in S2, ESI†).^{31–33}

In a 2D system, carrier mobility³⁴ can be calculated from the deformation potential approximation:

$$\mu_{2D} = \frac{e\hbar^3 C_{2D}}{kTm^*m_d(E_1^i)^2} \quad (1)$$

where C_{2D} is the direction-dependent elastic modulus, m^* is the effective mass of the carrier in the same direction, m_d is the average effective mass in the two directions given by

$m_d = \sqrt{m_x^*m_y^*}$ and E_1^i mimics the deformation energy constant of the carrier due to phonons for the i -th edge band along the transport direction through the relation $E_1^i = \Delta E_i/(\Delta l/l_0)$, where ΔE_i and $\Delta l/l_0$ represent the energy change of the i -th band and lattice dilation, respectively.

To perform chemical bonding analysis, we carried out single-point calculations (using the geometries obtained from VASP) to calculate the density of states (DOS), crystal overlap Hamiltonian population (COHP) using the LOBSTER package,³⁵ and electron localization function (ELF). Molecular orbital diagrams were generated *via* the extended Hückel method³⁶ using CACAO code.³⁷ Images of the crystalline structures reported in ESI (S3 and S4†) and crystal orbitals were produced using VESTA software package.³⁸

3. Results and discussion

Here, we take CuClSe₂ as a representative bulk example of isostructural CuXSe₂ title compounds (X = Cl, Br). CuClSe₂ crystallizes in the monoclinic space group $P2_1/c$ (No. 14) with two formula units per unit cell. The structure is isotypic to other copper(i) halide adducts to chalcogen chains with the composition CuXY₂ (X = halide, *i.e.*, Cl, Br; Y, chalcogen, *i.e.*, Se).

Fig. 1 shows drawings of the CuClSe₂ compound, viewed along different axes, while the DFT-optimized structural parameters are displayed in Table 1. The relevant PBE-D2-calculated distances are typical of single covalent bonds, and fit well with experimental structural parameters (see Table 1). CuClSe₂ structures contain formally neutral infinite one-dimensional selenium chains $\frac{1}{\infty}[\text{Se}]$ directed along the a -axis. Each polymeric chain has a helical structure composed of bent selenium atoms and single Se–Se bonds along the chains [$d_{(\text{Se}-\text{Se})} = 2.29$ and 2.57 Å for (Se–Se)_{in} and (Se–Se)_{out} bonds, respectively; see Fig. 1]. As shown in Fig. 1b, the substructure formed by the copper halides fits perfectly to the selenium chains. The selenium chains are coordinated to copper atoms on two sides *via* typical single Cu–Se bonds ($d_{(\text{Cu}-\text{Se})} = 2.37$ Å), creating a two-dimensional covalent net composed exclusively of edge shearing pentagons and heptagons. The obtained CuClSe₂ layers contain only tetrahedrally coordinated copper atoms. This local structural feature is expected for the 18-valence electron ML₄ unit (d^{10} Cu⁺: 10 electrons; two bridging $\mu\text{-Cl}^-$ ligands: 2×2 electrons; two R₂Se ligands or one bidentate RSe–(Se)₂–SeR ligand: 2×2 electrons). Finally, bulk CuClSe₂ is obtained through stacking of CuClSe₂ layers along the c -axis in such a manner that short interlayer Cl \cdots Se contacts are formed ($d = 3.42$ Å); these interactions are out of the covalent bonding range. An ABA sequence is observed; the top layer can be considered as a mirror-image of the bottom layer with an in-plane shift along the \vec{a} and \vec{b} directions (see Fig. 1). Thus, the 3D crystal structure of CuClSe₂ is based on these weak van der Waals interactions and approximates to a graphite-like material. We will discuss the binding energy between the covalent layers when we investigate exfoliation of this layered material later in this manuscript.



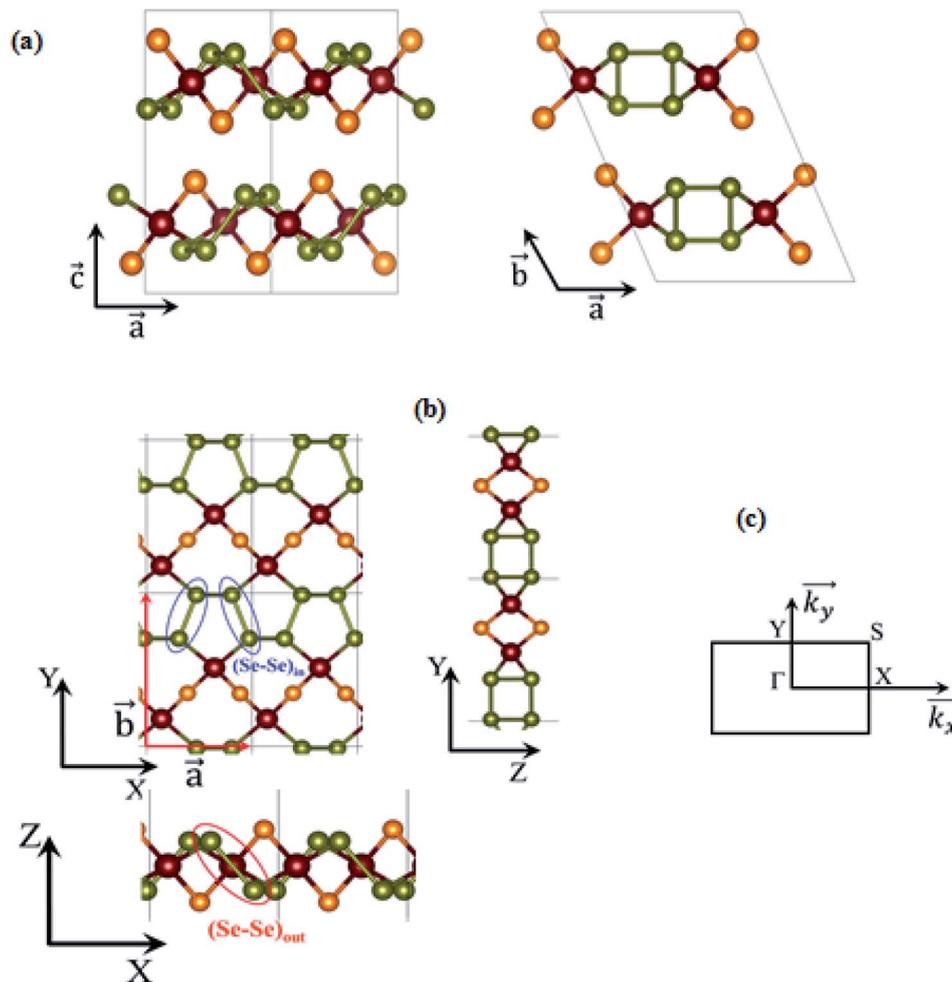


Fig. 1 Different views of the chemical structures of layered bulk CuXSe₂ (a), the CuXSe₂ monolayer (b), and the first Brillouin zone of CuXSe₂ monolayer and points of special symmetry (c). Primitive lattice vectors (\vec{a} , \vec{b}) and in-plane and out-of-plane Se–Se bonds, (Se–Se)_{in} and (Se–Se)_{out}, are shown. Orange, reddish-brown, and green circles represent halogen (X = Cl, Br), copper (Cu), and selenium (Se) atoms, respectively.

Table 1 PBE-D2-calculated lattice parameters (in Å), bond lengths (in Å) and angles (in degree, °) for bulk CuXSe₂ compared with the corresponding experimental data

CuXSe ₂		(<i>a</i> , <i>b</i> , <i>c</i> , γ)	<i>d</i> _{Cu-X}	<i>d</i> _{Cu-Se}	<i>d</i> _{Se-Se} ^a	<i>d</i> _{Se-X} ^b	\angle Se–Se–Se
X = Cl	Cal.	(4.87, 7.56, 14.19, 134.78)	2.289, 2.312	2.331, 2.373	2.287, 2.579	3.42	101.4, 104.2
	Exp.	(4.63, 7.68, 14.55, 132.79)	—	2.409, 2.420	2.316, 2.393	3.19	102.9, 104.4
X = Br	Cal.	(4.88, 7.86, 12.38, 114.53)	2.427, 2.428	2.361, 2.378	2.339, 2.521	3.59	103.0, 103.1
	Exp.	(4.64, 7.88, 11.18, 103.44)	2.421, 2.436	2.420, 2.436	2.339, 2.410	3.32	102.88, 104.25

^a The two values correspond to the (Se–Se)_{in} and (Se–Se)_{out} bond lengths, respectively. ^b Interlayer Se–X distances.

To assess the thermodynamic stability of CuXSe₂ nano-composites with respect to the bulk of their constituent partial structures, we calculated the related enthalpies of reaction ($\Delta_r H$) using the following equation:

$$\Delta_r H = [E(\text{CuXSe}_2)_{\text{bulk}} - (E(\text{CuX}) + 2 \times E(\text{Se}_\infty))] \quad (2)$$

where $E(\text{CuXSe}_2)$ and $E(\text{CuX})$ are the total energies of bulk CuXSe₂ and CuX ($F43m$ space group, No. 216) per formula unit. $E(\text{Se}_\infty)$ represents the total energy of bulk trigonal Se ($P3_121$ space group, No. 151) per atom (the optimized bulk crystal

structures of Se, CuCl and CuBr are presented in the ESI†). The calculated reaction energies are -0.37 eV and -0.34 eV for CuClSe₂ and CuBrSe₂, respectively, confirming the nano-composites are thermodynamically stable. The calculated values are in good agreement with experimentally obtained data for CuXSe₂ (>-0.52 eV).³⁹

From bulk to layers

CuXSe₂ monolayers were constructed by optimizing the atomic positions and lattice constants of single layers taken from the



bulk structures. Both CuClSe₂ and CuBrSe₂ monolayers are composed of a rectangular primitive cell with a $P2_1$ symmetry group (No. 4). As shown in Fig. 1b, the general structural features of the monolayers remain quite similar to those of the bulk structures after optimization. These results were expected based on the nature of the bonding—*i.e.*, weak van der Waals interactions—between the stacked covalent layers. The optimized lattice constants are calculated to be $a = 4.84$ Å and $b = 7.56$ Å for CuClSe₂ monolayers and $a = 4.86$ Å and $b = 7.70$ Å for CuBrSe₂ monolayers, which are slightly different from the respective values for the bulk structures.

Are the two-dimensional $P2_1$ CuXSe₂ (X = Cl, Br) structures viable?

To answer to this question, we investigated the thermodynamic, dynamic, mechanical and thermal stabilities of the structures. Note that an assessment of chemical stability, such oxidation processes, was not the purpose of the present study. Thus, we first evaluated the thermodynamic stability of 2D CuXSe₂ using the eqn (1) reaction in which the bulk phase is replaced by the 2D structure. The calculated reaction enthalpies at $T = 0$ K are negative: -0.09 and -0.08 eV per f.u. for the CuClSe₂ and CuBrSe₂ monolayers, respectively. Next, we quantified the ease of exfoliating CuXSe₂ by calculating the cleavage energy of its monolayers and bilayers from the bulk system.

The cleavage energy was computed as the energy difference between the ground state energies of (i) a six-layer slab, approximated as a model of the bulk, and (ii) a five (four)-layer slab plus a monolayer (bilayer) separated from the slab. As shown in Fig. 2, the cleavage energies are 0.24 and 0.25 J m⁻² for CuClSe₂ and CuBrSe₂ monolayers, respectively, which are slightly smaller than the cleavage energies calculated for the bilayers (0.25 and 0.26 J m⁻²). However, the slab method of calculating exfoliation energy has two main disadvantages: (i) it neglects further stabilization of the exfoliated monolayer due to a possible change in lattice constants and (ii) a thick slab is required to obtain reliable results. In 2018, Jung *et al.*⁴⁰ proposed an exact, simple method for calculating the exfoliation energy of layered materials. In this

method, the n -layer exfoliation energy per unit area ($E_{\text{exf}}(n)$) is calculated by: $E_{\text{exf}}(n) = (E_{\text{iso}}(n) - E_{\text{bulk}}(n/2))/A$ where $E_{\text{iso}}(n)$ is the energy of a fully optimized isolated n -layer CuXSe₂, $E_{\text{bulk}}/2$ is the energy of the bulk CuXSe₂ per layer, and A is the in-plane area of bulk CuXSe₂. The calculated $E_{\text{exf}}(1)$ and $E_{\text{exf}}(2)$ values are 0.24 and 0.26 J m⁻² for CuClSe₂ and 0.23 and 0.22 J m⁻² for CuBrSe₂, which are slightly different to the values obtained using the slab model. To compare these exfoliation energies with others, we calculated the exfoliation energy of graphene from graphite AB at PBE-D2 level of theory (see Fig. 2). Our calculated value (0.344 J m⁻²) is in very good agreement with the experimentally obtained value of 0.37 J m⁻² and another theoretically predicted value by Jung *et al.* (0.336 J m⁻²).^{40,41} Thus, one may see that the exfoliation energies of 2D CuXSe₂ are smaller than the theoretically value for graphene and many other 2D materials (*e.g.* theoretically predicted exfoliation energies: 0.37 J m⁻² for GeS,⁴² 0.63 J m⁻² for GeTe,⁴³ and 1.14 J m⁻² for GeP₃⁴⁴), indicating that monolayer or few-layer CuXSe₂ can be easily synthesized using mechanical or liquid-phase exfoliation methods. Our investigation demonstrates that these two-dimensional CuXSe₂ compounds could be directly fabricated or exfoliated from their bulk systems as free-standing or suspended monolayers.

As well as being thermodynamically stable, CuXSe₂ monolayers must also be dynamically and mechanically stable to exist. The dynamic stabilities of the monolayers were assessed by calculating their phonon dispersion spectra. As apparent from Fig. 3a and b, zero imaginary frequency is found in the phonon spectrum of the two 2D structures, confirming their dynamic stability. Our detailed analysis of the phonon-projected DOS shows that the highest frequency modes of both monolayers (~ 295 and 280 cm⁻¹ for CuClSe₂ and CuBrSe₂, respectively) contributed almost exclusively from vibration of the Se_∞. In addition, the highest frequency modes (~ 233 and ~ 190 cm⁻¹ for CuClSe₂ and CuBrSe₂, respectively) correspond to vibration of Cu–Se bonds. These values are close to that of tellurene (~ 200 cm⁻¹),⁴⁵ while appreciably smaller than those of strongly bonded covalent materials like GeP₃ (480 cm⁻¹)⁴⁴ and MoS₂ (473 cm⁻¹),⁴⁶ indicating relatively weak interactions occur between the Se_∞ and CuX nanochains.

Let us now turn our discussion to the mechanical stability of our proposed 2D crystalline $P2_1$ CuXSe₂ compounds. A 2D structure with a rectangular primitive cell is mechanically stable if it satisfies the following conditions: $C_{11}C_{22} - C_{12}^2 > 0$ and $C_{66} > 0$, where C_{11} , C_{22} , C_{12}^2 and C_{66} are the elastic constants.^{47,48} Within the framework of harmonic approximation, the elastic constants can be determined from a series of parabolic fittings of the strain energy (E_s) with respect to uniaxial and biaxial strain. The strain energy of a 2D material is defined as $E_s = 1/2C_{11}\epsilon_{xx}^2 + 1/2C_{22}\epsilon_{yy}^2 + C_{12}\epsilon_{xx}\epsilon_{yy} + 2C_{66}\epsilon_{xy}$, where E_s , ϵ_{xx} , ϵ_{yy} , and ϵ_{xy} are strain energy per unit area, uniaxial strain along the x and y axes, and shear strain, respectively. The calculated elastic constants for CuClSe₂ ($C_{11} = 21.25$ N m⁻¹, $C_{22} = 26.81$ N m⁻¹, $C_{12} = 6.63$ N m⁻¹, and $C_{66} = 9.74$ N m⁻¹) and CuBrSe₂ ($C_{11} = 12.57$ N m⁻¹, $C_{22} = 25.53$ N m⁻¹, $C_{12} = 7.68$ N m⁻¹, and $C_{66} = 1.92$ N m⁻¹) fully satisfy the mechanical stability criteria. To investigate more deeply the mechanical properties of CuXSe₂ monolayers, we computed their in-plane stiffnesses (C) and Poisson's ratios (ν) on the basis of the

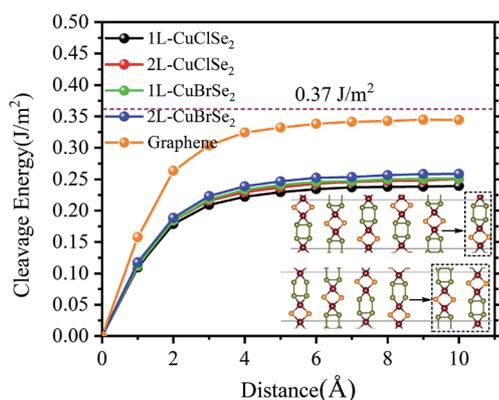


Fig. 2 Cleavage energy as a function of separation distance between the CuXSe₂ monolayer (bilayer) and five (four)-layer slab. The theoretical PBE-D2 and experimental exfoliation energies of graphene are also shown.



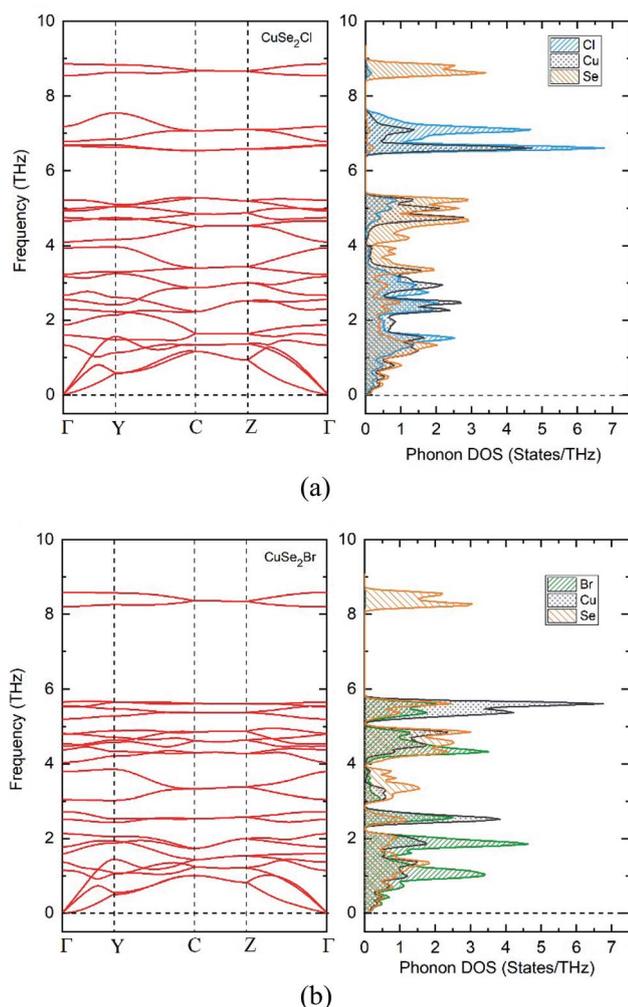


Fig. 3 Phonon dispersion for CuClSe₂ (a) and CuBrSe₂ (b) monolayers.

calculated elastic constants. In-plane stiffness along X and Y directions are defined as follows: $C_X = (C_{11}C_{22} - C_{12}^2)/C_{22}$ and $C_Y = (C_{11}C_{22} - C_{12}^2)/C_{11}$. CuClSe₂ has comparable stiffness along the X and Y directions ($C_X = 19.61$ and $C_Y = 24.74$ N m⁻¹), whereas CuBrSe₂ shows highly anisotropic mechanical behavior and is two times softer along the X direction ($C_X = 10.26$ N m⁻¹ and $C_Y = 20.83$ N m⁻¹). The stiffness values for the two monolayers are appreciably lower than those of graphene (350 N m⁻¹)⁴⁹ and MoS₂ (127 N m⁻¹).⁵⁰ The Poisson's ratios ($\nu_x = C_{12}/C_{22}$, $\nu_y = C_{12}/C_{11}$) are $\nu_x = 0.25$ and $\nu_y = 0.31$ for CuClSe₂. However, the Poisson's ratios for CuBrSe₂ ($\nu_x = 0.30$ and $\nu_y = 0.61$) also show strongly anisotropic behavior. In fact, the large ν_y value of CuBrSe₂ indicates that greater transverse contraction occurs in response to tensile strain along the Y direction than along the X direction. Recall that similar anisotropic Poisson's ratios ($\nu_{\text{armchair}} = 0.24$ and $\nu_{\text{zigzag}} = 0.81$) and in-plane stiffness ($C_{\text{armchair}} = 26.16$ and $C_{\text{zigzag}} = 88.02$ N m⁻¹) were observed for α phosphorene.⁵¹

Finally, we checked the thermal stability of 2D CuXSe₂ by running *ab initio* molecular dynamics (AIMD) simulations at 300 and 450 K for 5 ps (see technical details in the ESI[†]). Note that, experimentally, bulk CuClSe₂ melting point is about 601

K.²¹ As shown in Fig. S1,[†] the interchain (Cu–Se) and intrachain (Cu–X, Se–Se) bonds remain almost intact, even at temperatures as high as 450 K. The tetrahedral CuX₂Se₂ and selenium chain motifs persist up to 450 K, confirming the good thermal stabilities of 2D CuXSe₂ materials.

Electronic and bonding properties in two-dimensional CuXSe₂

Now, we focus our bonding discussion on the prototypical 2D $P2_1$ CuClSe₂ layer, which is isostructural and isovalent to CuBrSe₂. The formal oxidation formalism for CuClSe₂ is (Cu⁺)(Cl⁻)(Se₂). As mentioned previously, the CuClSe₂ layer contains two one-dimensional helical Cu₂Cl₂ and Se₄ chains running along the [100] direction with optimized PBE-D2 dihedral angles of 54.76°/56.85° and 32.26°/74.36°, respectively. These inorganic spirals are linked to each other through copper–selenium 2e–2c bonds, leading to five-membered CuSe₄ rings. Two-dimensional CuClSe₂ contains tetrahedrally coordinated copper atoms—CuCl₂Se₂ units—and bent Cl ligands. Each Se chain contains bent selenium atoms with alternating short (2.29 Å) and long (2.58 Å) single Se–Se bonds (2.40 Å in pure solid-state Se). These local atomic structural environments can be easily understood from simple electron counting and VSEPR theory. A Lewis structure—one localized bonding picture—of a CuClSe₂-based fragment is displayed in Fig. 4.

A tetrahedral environment is expected for this 18-valence electron CuCl₂Se₂ unit (d¹⁰ Cu⁺: 10 electrons; two bridging $\mu\text{-Cl}^-$ ligands: 2 × 2 electrons; two R₂Se ligands or one bidentate RSe(Se)₂–SeR ligand: 2 × 2 electrons). Along the spiral Se chain, each selenium is bent as expected based on VSEPR rules (AX₂E₂ center), while the helical form of the covalent Se chain is mainly due to repulsive interactions between the lone pairs located on each Se atom. The electronic structure of this periodical 2D crystalline structure can be understood by starting with an analysis of the orbitals of an isolated d¹⁰ tetrahedral CuL₄ fragment (L = two-electron donor ligand such as Cl⁻ or Se²⁻).

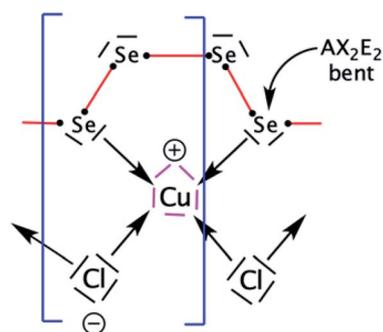


Fig. 4 Resonant Lewis structure of a CuCl₂Se₄ fragment found in the 2D $P2_1$ CuClSe₂ crystalline structure. The building block, CuClSe₂, is highlighted by the blue brackets. The five one pairs of d¹⁰ copper are shown in pink, while the 2e metal–ligand bonds are symbolized by arrows. The σ -bond skeleton of the 1D covalent selenium chain is displayed as red lines. VSEPR AX_nE_m notation is used (A, central atom; X, ligand and n , its number; E, lone pairs and m its number; $n + m$ is the steric number).



Let us start with a symmetric molecular model, T_d CuCl_4^{3-} (the charge was chosen to preserve the closed shell configuration corresponding to Cu^+ and Cl^-); the orbital interaction diagram is shown in Fig. 5. Only the σ orbitals—a pure p_σ atomic orbital if s–p mixing is weak (Cl case) or a hybrid sp orbital if not (Se case), as displayed in Fig. 5 on the far right—are taken into account here. One may also consider the π contributions from the ligand—one p_π orbital per sp^2 main group atom—though this leads to the same frontier orbitals picture, which has been previously studied by others.⁵²

First, d orbital splitting is observed, Cu e below Cu t_2 – HOMO, which is expected for a tetrahedral complex. The HOMO has significant contributions from the p orbitals of the ligands and the 3d orbitals of Cu, in an out-of-phase combination. Nevertheless, mixing of the Cu 4p orbitals into the HOMO with a Cu–L bonding phase renders the HOMO less antibonding. Thus, the three t_2 levels are fully occupied and metallic in character (HOMO) as the two e levels are occupied (d^{10} configuration). Second, the vacant Cu 4s and 4p atomic orbitals interact strongly with the occupied s and p levels of the ligand, leading to four occupied bonding s levels ($a_1 + t_2$) and four unoccupied antibonding levels. As the Cl 3p orbitals are above the 3d Cu AOs, the antibonding LUMO s Cu–L levels are more localized on the chlorine atoms.

Next, in our T_d CuL_4 model, we replaced the two Cl^- ligands with two Se^{2-} atoms, leading to C_{2v} $\text{CuCl}_2\text{Se}_2^{5-}$. The frontier orbital character remains: the HOMO is mainly Cu in character; whereas the LUMO is mainly Se (Cl is more electronegative than

Se). This is a localized picture of the chemical bonding in extended two-dimensional CuClSe_2 , highly simplified. Let trace possible electronic structure relationships between these molecular models (localized picture) and the extended net of two-dimensional CuClSe_2 (delocalized picture). To do so, the density of states (DOS) of CuClSe_2 can be decomposed into Cu, Cl and Se contributions, as illustrated in Fig. 6a. Moreover, chemical bonding analyses were also performed by computing the crystal orbital Hamilton population (COHP),³⁵ which allows identification of bonding and antibonding contributions to the electronic band structure by weighting the off-site projected DOS with the corresponding Hamiltonian matrix elements (hence, negative COHP values denote stabilizing interactions). Thus, integrated COHP (ICOHP) gives a measure of bond strength in the CuClSe_2 layers (see Fig. 6a).

At the top of the valence band, the states are mainly Cu 3d, as expected ($e + t_2$ levels, so called block d based on five filled orbitals, d^{10}). These states are only weakly Cu–Se and Cu–Cl antibonding due to the stabilizing effect of Cu 4p mixing into Cu 3d (see the COHP for Cu–Se and Cu–Cl in Fig. 6a). The DOS for the bottom of the conduction band is mainly Se in character, corresponding to the antibonding Se–Se σ^* levels as shown in projected Se–Se COHP curves (Fig. 6a).

The interactions between a Se atom with its two Se neighbors is estimated at -3.67 eV per pair (averaged value; -3.96 eV per pair in elemental $P3_121$ Se), indicative of a stronger covalent character along the single-bonded selenium chains. Here, the computed copper-ligand ICOHP values are -1.62 eV per pair (Cu–Se) and -1.34 eV per pair (Cu–Cl), reflecting rather weaker Cu–L covalent bonding. We calculated the electron localization function (ELF) to obtain more insight into the nature of the Cu–Se/Cl bonds in CuXSe_2 . ELF can quantitatively distinguish different types of chemical bonds by assigning values in the range of 0 to 1 to each point of real space; generally, regions with ELF values close to 1 indicate strong covalent bonding or lone pair electrons, while lower ELF values correspond to metallic or ionic bonds and low electron density localization. From the ELF counter maps of CuClSe_2 and CuBrSe_2 shown in ESI Fig. S2,[†] one can clearly see electrons are strongly localized around the selenium and halogen atoms, as expected from our Lewis structures that assign lone pairs on Se and halogen atoms (see Fig. 4). Finally, Fig. 6b proposed a conceptual and simplified bridge between the molecular tetrahedral ML_4 model and extended net of two-dimensional CuClSe_2 electronic structures.

What about the metallicity of these two-dimensional materials? With formal d^{10} ML_4 tetrahedra forming the slab, CuXSe_2 should be an insulator or, at least, a semiconductor. The band structure and DOS of the 2D material shown in Fig. 7 agree with this statement. A HSE06 indirect gap of ~ 1.7 eV is computed between the valence and conduction bands for CuClSe_2 (1.73 eV) and CuBrSe_2 (1.74 eV). For both materials, the valence band maximum (VBM) is located at the Y point, whereas the conduction band minimum (CBM) lies on the Γ point (see the band structures displayed in Fig. 7). Although Cl atoms are more electronegative than Br atoms, one may wonder why both materials show almost equal band gaps? Our electronic

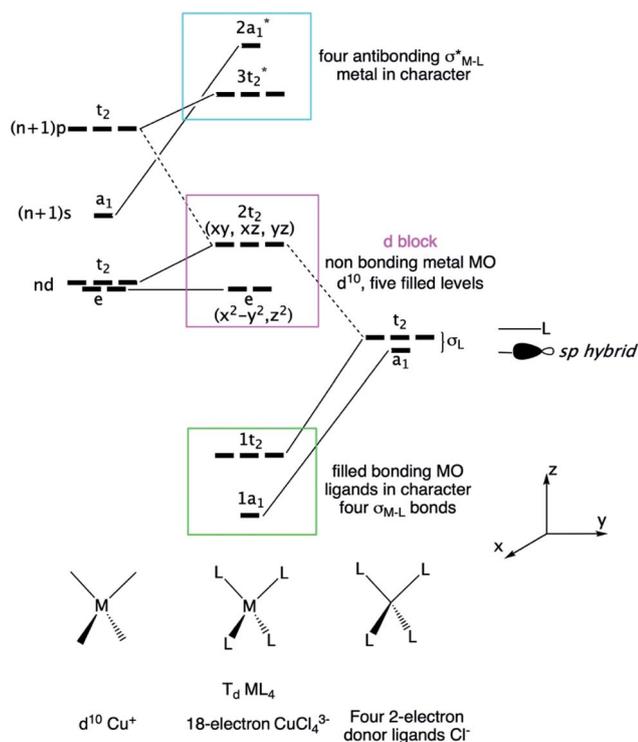
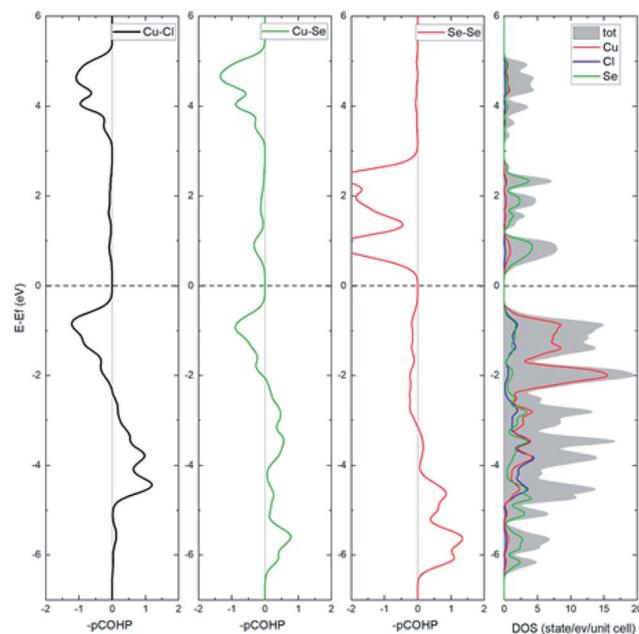
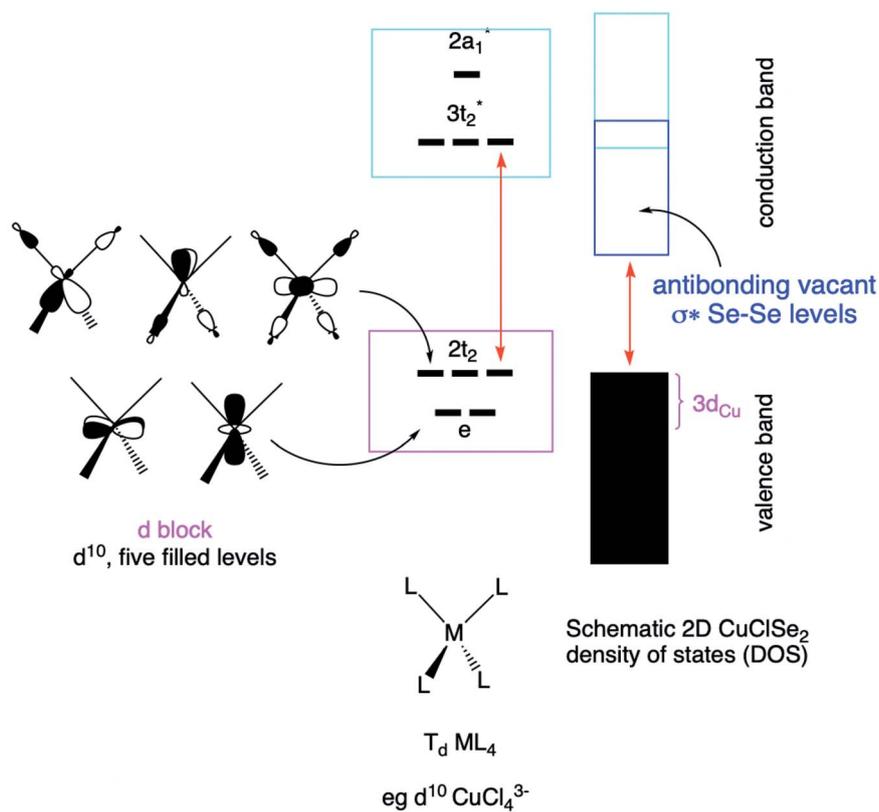


Fig. 5 Molecular orbital derivation of the frontier orbitals of a tetrahedral ML_4 complex. The CuCl_4^{3-} fragment with d^{10} Cu^+ and 2-electron Cl^- ligands is taken as a model.





(a)



(b)

Fig. 6 (a) Calculated COHP curves and DOS for two-dimensional $P2_1$ CuClSe_2 . (b) Schematic of the 2D $P2_1$ CuClSe_2 density of states. The metal MO levels of the isolated d^{10} tetrahedral ML_4 fragment are displayed on the left.

structure analysis shows that for both materials, the VBM is mainly derived from Cu d orbitals, with minor contributions from the p orbitals of Se and X atoms. However, the CBM comes

almost exclusively from the valence orbitals of Se atoms. Consequently, Cl and Br have minor contributions to the band edge states, resulting in almost equal band gaps.



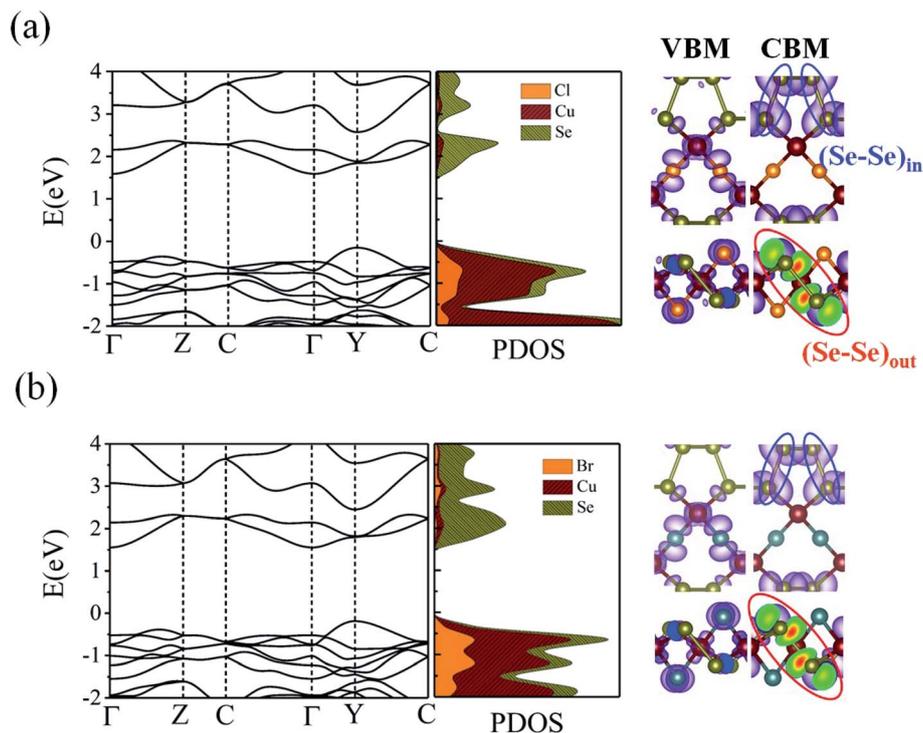


Fig. 7 HSE06 band structures and the corresponding partial density of states (PDOS) for (a) CuClSe_2 (a) and CuBrSe_2 (b) monolayers. The charge density distributions of the VBM and CBM are also shown for each monolayer.

From monolayers to bilayers

We also calculated the electronic band structures of CuXSe_2 bilayers to examine the effect of decreasing quantum confinement on the electronic properties of the monolayers. The same stacking pattern used for bulk CuXSe_2 was used to construct the bilayers. Fig. 8 shows the HSE06 electronic band structures and charge density distributions of the VBM and CBM for both CuClSe_2 and CuBrSe_2 bilayers. The bilayers exhibit indirect band gaps of 1.54 and 1.59 eV for CuClSe_2 and CuBrSe_2 , respectively; these values are slightly lower than those of the corresponding monolayers. The decrease in the band gap from mono to bilayer formation is 0.19 eV for CuClSe_2 and 0.15 eV for CuBrSe_2 , appreciably smaller than the change for phosphorene (0.49 eV),⁵³ indicating much weaker quantum confinement effects in CuXSe_2 . To understand this, we carefully analyzed the charge density distribution in the VBM and CBM of CuXSe_2 bilayers. The CBM represents a weak bonding interaction between the CBMs of two layers, while the VBM represents a non-bonding interaction between the VBMs of two layers (Fig. 8). Therefore, the bilayer CBM is more stable compared to the monolayer, while the VBM remains almost unchanged, resulting in slightly smaller band gaps for CuXSe_2 bilayers.

Carrier mobility of the proposed 2D copper halide selenium materials

Next, we investigated the carrier (electron and hole) mobility of CuXSe_2 monolayers along the x and y directions using effective mass approximation and deformation potential theory. In fact, high charge transport in 2D materials has a profound influence

on the performance of electronic devices. Table 2 presents the calculated elastic modulus (C_{2D}), effective mass (m_i^*), deformation potential constant (E_1^D), and carrier mobility (μ_i) of CuXSe_2 monolayers. Both monolayers show extraordinarily

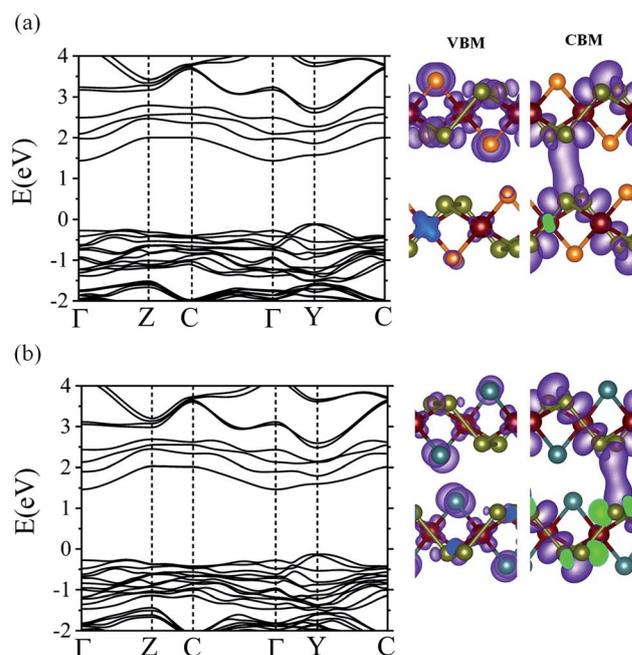


Fig. 8 HSE06 band structures of CuClSe_2 (a) and CuBrSe_2 (b) bilayers. Charge density distributions of the VBM and CBM are also shown for each system.



Table 2 Elastic modulus (C_{2D}), effective mass (m_e^* , m_h^*) of electrons and holes with respect to the free-electron mass (m_0), deformation potential constant of VBM and CBM (E_{VBM}^1 , E_{CBM}^1), and mobility (μ_e , μ_h) of electrons and holes along X and Y directions for CuXSe₂ monolayers. All parameters were calculated using the HSE06 functional^a

Material	Direction	C_{2D} (J m ⁻²)	Electron			Hole		
			m_e^*	E_{CBM}^1 (eV)	μ_e	m_h^*	E_{VBM}^1 (eV)	μ_h
CuClSe ₂	X	19.61	1.30	3.737	27.673	1.17	0.588	2054.206
	Y	24.74	1.23	0.155	21 263.445	0.81	3.644	98.298
CuBrSe ₂	X	10.26	1.22	3.850	16.289	1.47	0.558	892.608
	Y	20.83	1.22	0.229	10 274.830	0.73	3.620	95.645

^a Mobility at 300 K, cm² V⁻¹ s⁻¹.

anisotropic charge transport along the x and y directions. The electron mobilities along the y direction are 21 263.45 and 10 274.83 cm² V⁻¹ s⁻¹ for CuClSe₂ and CuBrSe₂, respectively, which are ~768 and 631 times larger than the values along x direction (27.67 and 16.29 cm² V⁻¹ s⁻¹). However, the opposite trend is observed for hole mobility: the mobilities along the y direction (98.30 and 95.64 cm² V⁻¹ s⁻¹) are 20 and 9 times smaller than the values along the x direction (2054.21 and 892.61 cm² V⁻¹ s⁻¹). In other words, electron transport occurs almost exclusively along the y direction, while holes highly favor the x direction. This effectively separates the photo-generated electron-hole pairs, which indicates the monolayers hold promise for application in photovoltaic cells and photocatalysis. The calculated mobilities are in the same range as those of phosphorene (~10 000 cm² V⁻¹ s⁻¹),⁵³ and appreciably larger than those of other 2D materials like MnPSe₃ (~626 cm² V⁻¹ s⁻¹)⁵⁴ and MoS₂ (~200 cm² V⁻¹ s⁻¹).⁵⁰ According to Table 2, the anisotropic charge transport mainly originates from the highly direction-dependent deformation potentials for both electrons and holes. Specifically, the E_{CBM}^1 values along the y direction are 0.16 and 0.23 eV for CuClSe₂ and CuBrSe₂, respectively, which are about 24 and 17 times smaller than the corresponding values along the x direction (3.74 and 3.85 eV). This observation can be rationalized when one considers that the CBM for both monolayers represents weak (Se-Se)_{in} π bonds along the y direction and (Se-Se)_{out} σ^* bonds along the x direction (Fig. 7). Accordingly, we can confidently say that

(Se-Se)_{out} σ^* bonds are much more sensitive to lattice dilation than weak (Se-Se)_{in} π bonds, which have much larger E_{CBM}^1 values along x.

Optical performance of CuXSe₂ monolayers

Their good stability, ease of exfoliation, moderate band gap and extraordinary anisotropic charge transport make CuXSe₂ monolayers promising potential candidates for optoelectronics applications. Thus, we examined the optical performance of CuXSe₂ monolayers by calculating their frequency-dependent complex dielectric constants using the HSE06 method. As shown in Fig. 9, the monolayers obviously absorb light over a broad range of the visible spectrum (2 to 3.2 eV). The monolayers also show anisotropic absorbance coefficients, similarly to phosphorene. In spite of their indirect band gaps, the calculated absorbance coefficients (>10⁵ cm⁻¹) are comparable to those of hybrid halide perovskites, which are highly efficient light harvesting materials employed in solar cells.^{55,56}

Strain effects

We also examined the effect of strain on the electronic band structure of CuXSe₂ monolayers. We only focused on biaxial tensile strain up to 8%, as compression is barely achievable experimentally. The strain energies at 8% are 50 meV per atom for CuClSe₂ and 44 meV per atom for CuBrSe₂, slightly larger than the thermal energy at room temperature (25 meV per atom), indicating its energetically feasible. Fig. 10 shows the

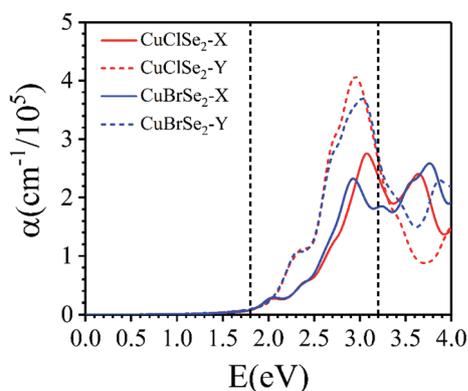


Fig. 9 Frequency-dependent absorption coefficients of CuXSe₂ monolayers. The energy range corresponding to visible light is indicated by vertical dashed lines.

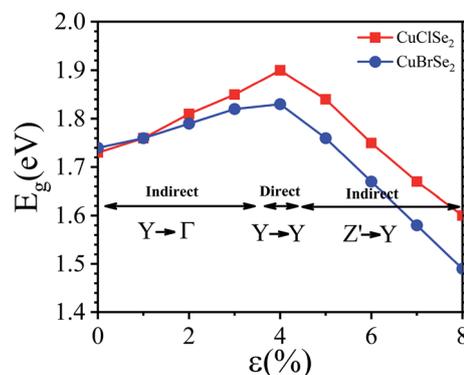


Fig. 10 Band gap variation of the CuXSe₂ monolayers as a function of biaxial strain.



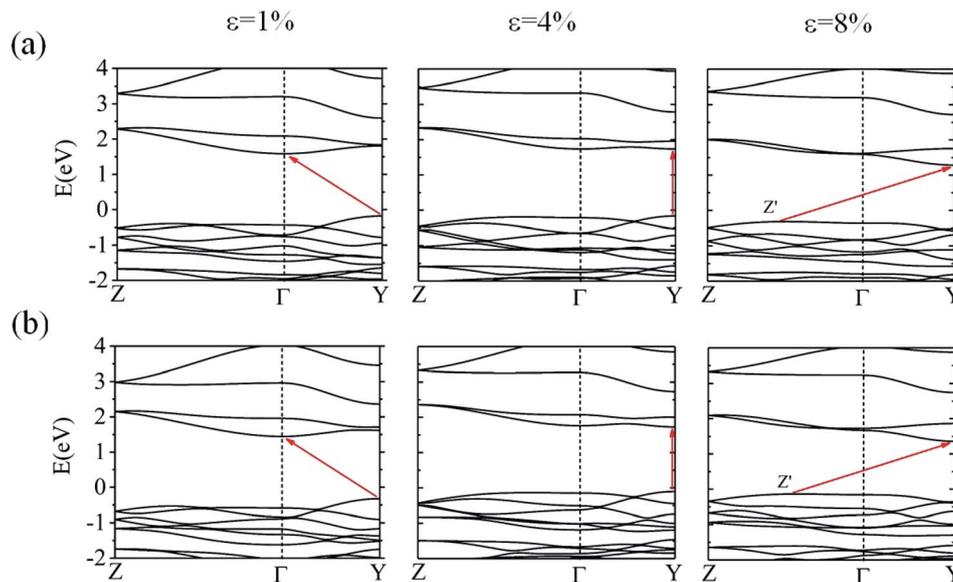


Fig. 11 The HSE06 band structures of CuClSe₂ (a) and CuBrSe₂ (b) under 1%, 4% and 8% biaxial tensile strain.

band gap initially increases as strain increases for both monolayers, reaching maximums of 1.90 eV for CuClSe₂ and 1.83 eV for CuBrSe₂ at 4%, and then decreases at 8% to 1.60 eV for CuClSe₂ and 1.49 eV for CuBrSe₂. The nature of the band gap also sensitively responds to strain, as each monolayer experiences indirect–direct–indirect band gap transitions (Fig. 11). The gap remains indirect up to 3%, while the CBM moves from Γ -point to Y-point at 4%, resulting in an indirect-to-direct band gap transition. Moreover, at 5%, the VBM moves to Z', which lies on the Z \rightarrow Γ path, again transforming the monolayers to indirect band gap semiconductors.

4. Conclusion

We systematically investigated the structural, mechanical, electronic and optical properties of CuXSe₂ (X = Cl, Br) nanocomposite monolayers and bilayers using first-principles DFT calculations. Exfoliation from CuXSe₂ (X = Cl, Br) layered bulk phases is computationally feasible based on the small cleavage energies. In addition, the phonon spectrum, calculated elastic constants and AIMD simulations suggest freestanding 2D CuXSe₂ (X = Cl, Br) are dynamically, mechanically and thermodynamically stable. The monolayers are indirect-gap semiconductors with practically the same band gaps (1.73 eV for CuClSe₂ and 1.74 eV for CuBrSe₂) and exhibit extremely anisotropic and very high carrier mobilities. We found that intrinsic charge transport in CuXSe₂ is almost exclusively unidirectional for electrons and holes (*i.e.*, electron mobilities are 21 263.45 and 10 274.83 cm² V⁻¹ s⁻¹ along the y direction for CuClSe₂ and CuBrSe₂, respectively, while hole mobilities are 2054.21 and 892.61 cm² V⁻¹ s⁻¹ along the x direction). These results indicate very good separation of photogenerated electron–hole pairs. CuXSe₂ bilayers are also indirect band gap semiconductors with slightly smaller band gaps of 1.54 and 1.59 eV for CuClSe₂ and CuBrSe₂, respectively, suggesting weak interlayer quantum

confinement effects. On the other hand, CuXSe₂ monolayers have high absorption coefficients (>10⁵ cm⁻¹) over a wide range of the visible light spectrum. Their moderate band gaps, very high unidirectional electron and hole mobilities, and high absorption coefficients indicate the proposed CuXSe₂ (X = Cl, Br) nanocomposite monolayers hold promise for applications in optoelectronic devices.

Conflicts of interest

There are no conflicts to declare.

Acknowledgements

The authors thank Shahid Chamran University of Ahvaz, the School of Nanoscience, Institute for Research in Fundamental Sciences (IPM), CNRS and Nouvelle Aquitaine Region – FEDER for supporting this scientific research. This research was partially supported by the Research Council of Shahid Chamran University of Ahvaz (GN 1398), the Center for International Scientific & Collaboration (CISSC) Ministry of Science Research and Technology, the Hubert Curien Partnership PHC Gundishapur 2019 (No. 42961 PF, PI G. F.) and PRCI ANR Predict_2D_NanoMat (PI G. F.). We also acknowledge the High-Performance Computing Centers of Poitiers University (Meso-centre SPIN) and the GENCI (TGCC/Irene and CINES/Occigen, France) under Project No. X2016087539 for allocation of computing time.

References

- 1 K. S. Novoselov, A. K. Geim, S. V. Morozov, D. Jiang, Y. Zhang, S. V. Dubonos, I. V. Grigorieva and A. A. Firsov, *Science*, 2004, **306**, 666–669.
- 2 A. K. Geim and K. S. Novoselov, *Nat. Mater.*, 2007, **6**, 183–191.



- 3 Q. H. Wang, K. Kalantar-Zadeh, A. Kis, J. N. Coleman and M. S. Strano, *Nat. Nanotechnol.*, 2012, **7**, 699–712.
- 4 L. Li, Y. Yu, G. J. Ye, Q. Ge, X. Ou, H. Wu, D. Feng, X. H. Chen and Y. B. Zhang, *Nat. Nanotechnol.*, 2014, **9**, 372–377.
- 5 Y. Zheng, Y. Jiao, L. Ge, M. Jaroniec and S. Z. Qiao, *Angew. Chem., Int. Ed.*, 2013, **52**, 3110–3116.
- 6 M. A. Lukowski, A. S. Daniel, F. Meng, A. Forticaux, L. Li and S. Jin, *J. Am. Chem. Soc.*, 2013, **135**, 10274–10277.
- 7 S. Yang, Y. Gong, J. Zhang, L. Zhan, L. Ma, Z. Fang, R. Vajtai, X. Wang and P. M. Ajayan, *Adv. Mater.*, 2013, **25**, 2452–2456.
- 8 K. S. Kumar, N. Choudhary, Y. Jung and J. Thomas, *ACS Energy Lett.*, 2018, **3**, 482–495.
- 9 K.-S. Chen, I. Balla, N. S. Luu and M. C. Hersam, *ACS Energy Lett.*, 2017, **2**, 2026–2034.
- 10 X. Li and L. Zhi, *Chem. Soc. Rev.*, 2018, **47**, 3189–3216.
- 11 H. Liu, A. T. Neal, Z. Zhu, Z. Luo, X. Xu, D. Tománek and P. D. Ye, *ACS Nano*, 2014, **8**, 4033–4041.
- 12 A. J. Mannix, B. Kiraly, M. C. Hersam and N. P. Guisinger, *Nat. Rev. Chem.*, 2017, **1**, 0014–14.
- 13 F. Wang, T. A. Shifa, P. Yu, P. He, Y. Liu, F. Wang, Z. Wang, X. Zhan, X. Lou, F. Xia and J. He, *Adv. Funct. Mater.*, 2018, **28**, 1802151–1802224.
- 14 T. L. Tan, H. M. Jin, M. B. Sullivan, B. Anasori and Y. Gogotsi, *ACS Nano*, 2017, **11**, 4407–4418.
- 15 T. Gao, Q. Zhang, L. Li, X. Zhou, L. Li, H. Li and T. Zhai, *Adv. Opt. Mater.*, 2018, **6**, 1800058–1800073.
- 16 A. Rabenau and H. Rau, *Solid State Commun.*, 1969, **7**, 1281–1282.
- 17 W. Milius and A. Rabenau, *Z. Naturforsch. B Chem. Sci.*, 1988, **43**, 243–244.
- 18 A. Pfitzner, T. Nilges and H.-J. Deiseroth, *Z. Anorg. Allg. Chem.*, 1999, **625**, 201–206.
- 19 J. Fenner, *Acta Crystallogr., Sect. B: Struct. Crystallogr. Cryst. Chem.*, 1976, **32**, 3084–3086.
- 20 W. Milius, *Z. Naturforsch. B Chem. Sci.*, 1989, **44**, 990–992.
- 21 Y. Wang, Z. Deng, X. Lv, F. Miao, S. Wan, X. Fang, Q. Zhang and S. Yin, *Mater. Lett.*, 2009, **63**, 236–238.
- 22 Y.-Q. Liu, H.-D. Wu, Y. Zhao and G.-B. Pan, *RSC Adv.*, 2014, **4**, 45844–45847.
- 23 G. Kresse and D. Joubert, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1999, **59**, 1758–1775.
- 24 G. Kresse and J. Hafner, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1993, **47**, 558–561.
- 25 G. Kresse and J. Furthmuller, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1996, **54**, 11169–11186.
- 26 J. P. Perdew, K. Burke and M. Ernzerhof, *Phys. Rev. Lett.*, 1996, **77**, 3865–3868.
- 27 S. Grimme, *J. Comput. Chem.*, 2006, **27**, 1787–1799.
- 28 A. V. Krukau, O. A. Vydrov, A. F. Izmaylov and G. E. Scuseria, *J. Chem. Phys.*, 2006, **125**, 224106–224110.
- 29 L. Chaput, A. Togo, I. Tanaka and G. Hug, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2011, **84**, 094302–094306.
- 30 A. Togo, F. Oba and I. Tanaka, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2008, **78**, 134106–134109.
- 31 S. Nose, *J. Chem. Phys.*, 1984, **81**, 511–519.
- 32 S. Nose, *Prog. Theor. Phys. Suppl.*, 1991, **103**, 1–46.
- 33 D. M. Bylander and L. Kleinman, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1992, **46**, 13756–13761.
- 34 J. Bardeen and W. Shockley, *Phys. Rev.*, 1950, **80**, 72–80.
- 35 R. Dronskowski and P. E. Bloechl, *J. Phys. Chem.*, 1993, **97**, 8617–8624; S. Maintz, V. L. Deringer, A. L. Tchougreff and R. Dronskowski, *J. Comput. Chem.*, 2013, **34**, 2557–2567.
- 36 R. Hoffmann, *J. Chem. Phys.*, 1963, **39**, 1397–1412.
- 37 C. Mealli and D. M. Proserpio, *J. Chem. Educ.*, 1990, **67**, 399–402.
- 38 K. Momma and F. Izumi, *J. Appl. Crystallogr.*, 2008, **41**, 653–658.
- 39 A. Rabenau, H. Rau and G. Rosenstein, *Z. Anorg. Allg. Chem.*, 1970, **374**, 43–53.
- 40 J. H. Jung, C.-H. Park and J. Ihm, *Nano Lett.*, 2018, **18**, 2759–2765.
- 41 W. Wang, S. Dai, X. Li, J. Yang, D. J. Srolovitz and Q. Zheng, *Nat. Commun.*, 2015, **6**, 7853–7859.
- 42 F. Li, X. Liu, Y. Wang and Y. Li, *J. Mater. Chem. C*, 2016, **4**, 2155–2159.
- 43 M. Qiao, Y. Chen, Y. Wang and Y. Li, *J. Mater. Chem. A*, 2018, **6**, 4119–4125.
- 44 Y. Jing, Y. Ma, Y. Li and T. Heine, *Nano Lett.*, 2017, **17**, 1833–1838.
- 45 Z. Zhu, X. Cai, S. Yi, J. Chen, Y. Dai, C. Niu, Z. Guo, M. Xie, F. Liu, J.-H. Cho, Y. Jia and Z. Zhang, *Phys. Rev. Lett.*, 2017, **119**, 106101–106105.
- 46 A. Molina-Sánchez and L. Wirtz, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2011, **84**, 155413–155418.
- 47 S. Zhang, J. Zhou, Q. Wang, X. Chen, Y. Kawazoe and P. Jena, *Proc. Natl. Acad. Sci. U. S. A.*, 2015, **112**(8), 2372–2377.
- 48 Y. Wang, F. Li, Y. Li and Z. Chen, *Nat. Commun.*, 2016, **7**, 11488–11494.
- 49 T. Jiang, R. Huang and Y. Zhu, *Adv. Funct. Mater.*, 2014, **24**, 396–402.
- 50 Y. Cai, G. Zhang and Y.-W. Zhang, *J. Am. Chem. Soc.*, 2014, **136**, 6269–6275.
- 51 M. Elahi, K. Khaliji, S. M. Tabatabaei, M. Pourfath and R. Asgari, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2015, **91**, 115412–115418.
- 52 T. A. Albright, J. K. Burdett and M.-H. Whangbo, *Orbital Interactions in Chemistry*, Wiley, 2nd edn, 2013, ISBN: 9780471080398.
- 53 J. Qiao, X. Kong, Z.-X. Hu, F. Yang and W. Ji, *Nat. Commun.*, 2014, **5**, 4475–4484.
- 54 X. Zhang, X. Zhao, D. Wu, Y. Jing and Z. Zhou, *Adv. Sci.*, 2016, **3**, 1600062–1600065.
- 55 M. Shirayama, H. Kadowaki, T. Miyadera, T. Sugita, M. Tamakoshi, M. Kato, T. Fujiseki, D. Murata, S. Hara, T. N. Murakami, S. Fujimoto, M. Chikamatsu and H. Fujiwara, *Phys. Rev. Appl.*, 2016, **5**, 014012–014025.
- 56 G. Mannino, A. Alberti, I. Deretzis, E. Smecca, S. Sanzaro, Y. Numata, T. Miyasaka and A. L. Magna, *J. Phys. Chem. C*, 2017, **121**, 7703–7710.

